

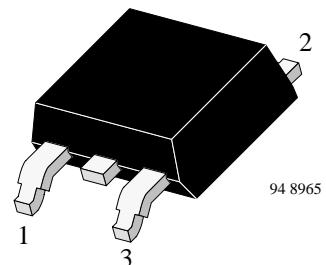
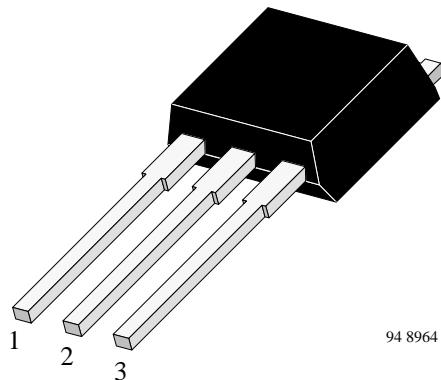
Silicon NPN High Voltage Switching Transistor

Features

- Simple-sWitch-Off Transistor (SWOT)
- HIGH SPEED technology
- Planarpassivation
- 100 kHz switching rate
- Very low switching losses
- Very low dynamic saturation
- Very low operating temperature
- Optimized RBSOA
- High reverse voltage

Applications

Electronic lamp ballast circuits
Switch-mode power supplies



BUD616A
1 Emitter 2 Collector 3 Base

BUD616A -SMD
1 Emitter 2 Collector 3 Base

Absolute Maximum Ratings

$T_{case} = 25^\circ\text{C}$, unless otherwise specified

Parameter	Test Conditions	Symbol	Value	Unit
Collector-emitter voltage		V_{CEO}	450	V
		V_{CES}	1000	V
Emitter-base voltage		V_{EBO}	12	V
Collector current		I_C	1.6	A
Collector peak current		I_{CM}	2.4	A
Base current		I_B	0.8	A
Base peak current		I_{BM}	1.2	A
Total power dissipation	$T_{case} \leq 50^\circ\text{C}$	P_{tot}	20	W
Junction temperature		T_j	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-65 to +150	$^\circ\text{C}$

Maximum Thermal Resistance

T_{case} = 25°C, unless otherwise specified

Parameter	Test Conditions	Symbol	Value	Unit
Junction case		R _{thJC}	5	K/W

Electrical Characteristics

T_{case} = 25°C, unless otherwise specified

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Collector cut-off current	V _{CE} = 1000 V	I _{CES}			50	µA
	V _{CE} = 1000 V; T _{case} = 125°C	I _{CES}			0.5	mA
Collector-emitter breakdown voltage (figure 1)	I _C = 300 mA; L = 125 mH; I _{measure} = 100 mA	V _{(BR)CEO}	450			V
Emitter-base breakdown voltage	I _E = 1 mA	V _{(BR)EBO}	12			V
Collector-emitter saturation voltage	I _C = 0.25 A; I _B = 65 mA	V _{CEsat}			0.2	V
	I _C = 0.8 A; I _B = 250 mA	V _{CEsat}			0.4	V
Base-emitter saturation voltage	I _C = 0.25 A; I _B = 65 mA	V _{BEsat}			1	V
	I _C = 0.8 A; I _B = 250 mA	V _{BEsat}			1.2	V
DC forward current transfer ratio	V _{CE} = 5 V; I _C = 0.2 mA	h _{FE}	17			
	V _{CE} = 5 V; I _C = 300 mA	h _{FE}	25			
	V _{CE} = 5 V; I _C = 480 mA	h _{FE}	12			
	V _{CE} = 5 V; I _C = 1.6 A	h _{FE}	4			

Switching Characteristics

$T_{case} = 25^\circ\text{C}$, unless otherwise specified

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Resistive load (figure 2)						
Turn on time	$I_C = 250 \text{ mA}; I_{B1} = 65 \text{ mA}; -I_{B2} = 130 \text{ mA}; V_S = 250 \text{ V}$	t_{on}			0.2	μs
Storage time		t_s			5	μs
Fall time		t_f			0.4	μs
Turn on time	$I_C = 0.8 \text{ A}; I_{B1} = 160 \text{ mA}; -I_{B2} = 0.4 \text{ A}; V_S = 250 \text{ V}$	t_{on}			1	μs
Storage time		t_s			2.5	μs
Fall time		t_f			0.2	μs
Inductive load (figure 3)						
Storage time	$I_C = 250 \text{ mA}; I_{B1} = 65 \text{ mA}; -I_{B2} = 130 \text{ mA}; V_{clamp} = 300 \text{ V}; L = 200 \mu\text{H}$	t_s			5	μs
Fall time		t_f			0.3	μs
Storage time	$I_C = 0.8 \text{ A}; I_{B1} = 160 \text{ mA}; -I_{B2} = 0.4 \text{ A}; V_{clamp} = 300 \text{ V}; L = 200 \mu\text{H}$	t_s			2.5	μs
Fall time		t_f			0.15	μs

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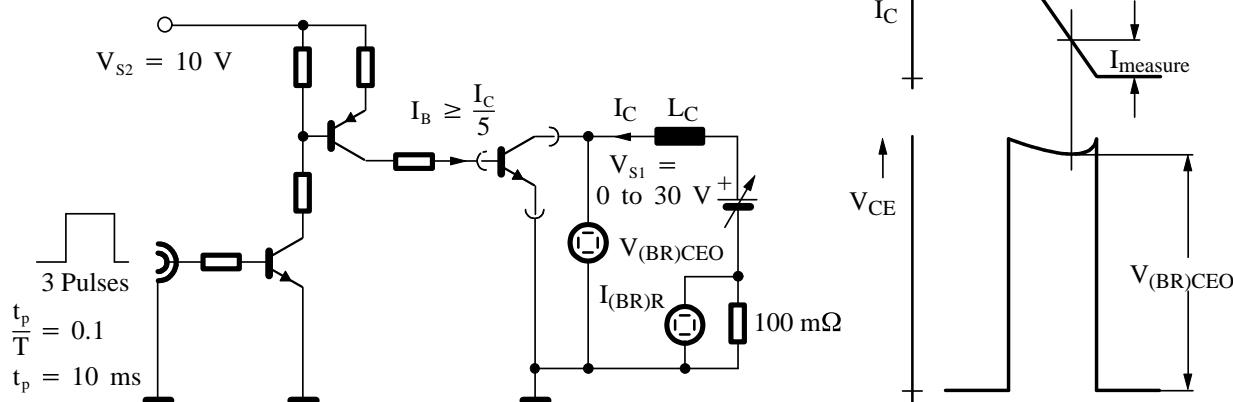
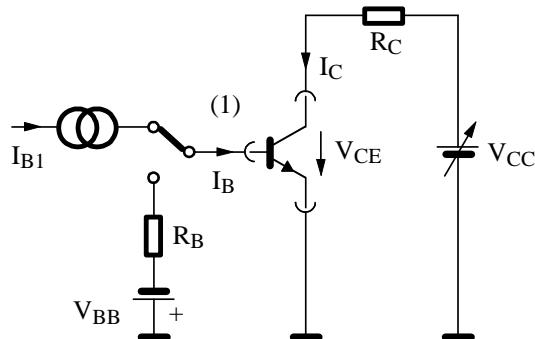


Figure 1. Test circuit for $V_{(BR)CEO}$

BUD616A

TEMIC
TELEFUNKEN Semiconductors

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(1) Fast electronic switch

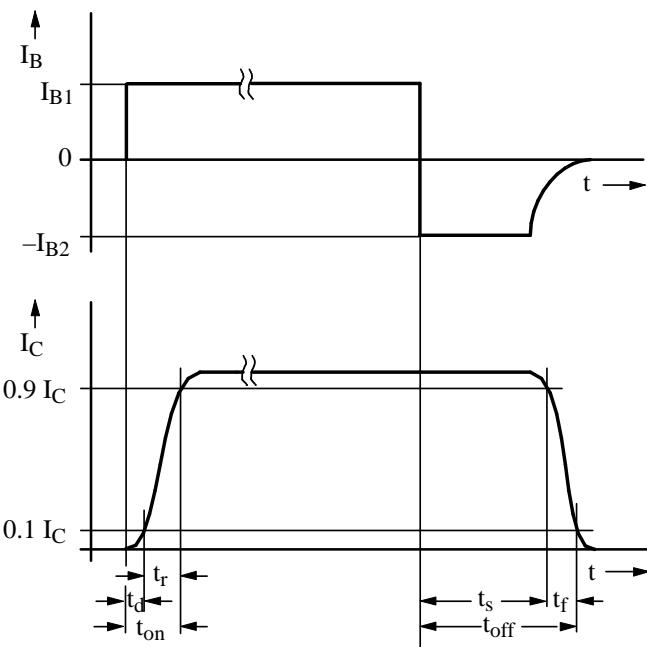
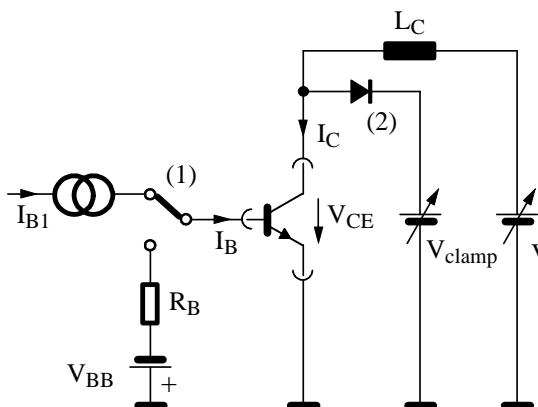


Figure 2. Test circuit for switching characteristics – resistive load

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(1) Fast electronic switch
(2) Fast recovery rectifier

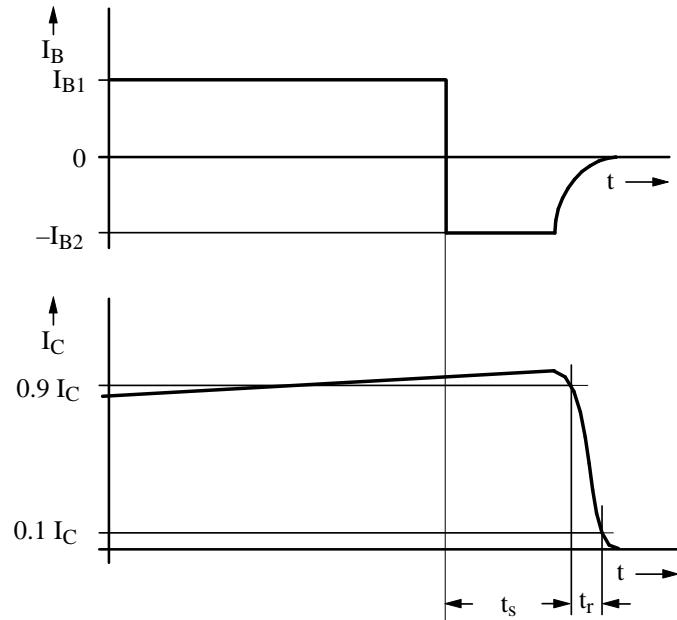
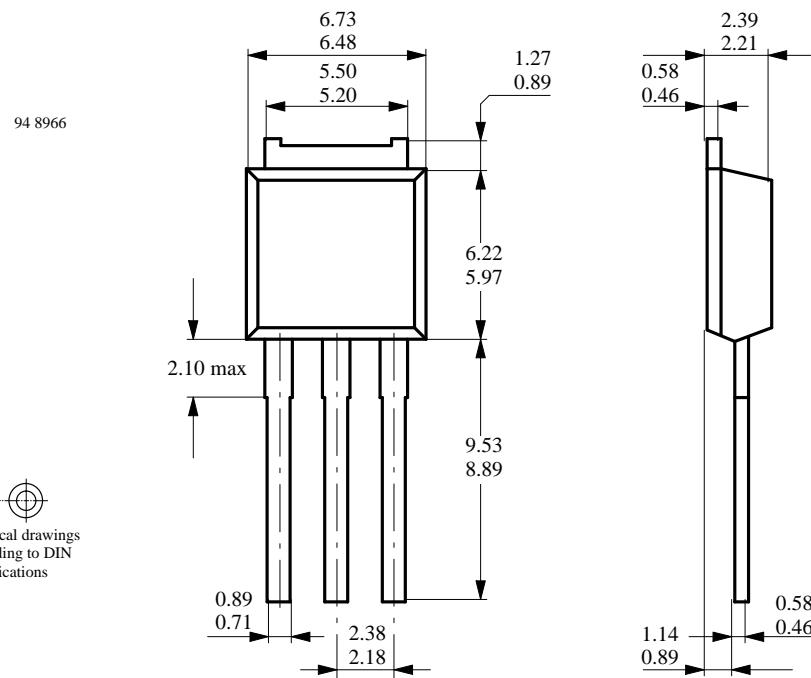


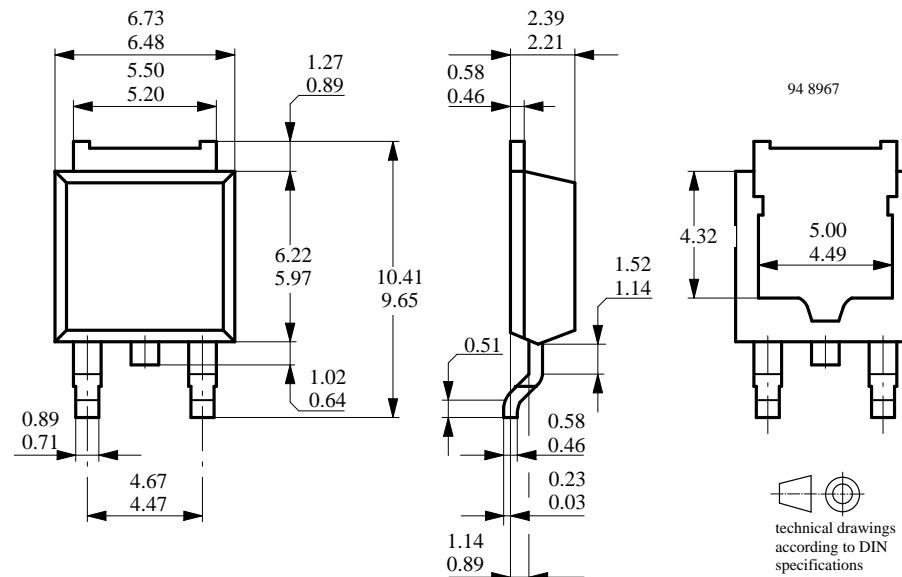
Figure 3. Test circuit for switching characteristics – inductive load

Dimensions in mm

TO251



TO252



For ordering TO 252 add SMD to the type number (i.e. BUD616A -SMD)

Ozone Depleting Substances Policy Statement

It is the policy of **TEMIC TELEFUNKEN microelectronic GmbH** to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

TEMIC TELEFUNKEN microelectronic GmbH semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

TEMIC can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design and may do so without further notice.

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use TEMIC products for any unintended or unauthorized application, the buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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